

Notice of References Cited	Application/Control No. 10/781,159	Applicant(s)/Patent Under Reexamination BACKES ET AL.	
	Examiner TAN TRINH	Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,907,229	06-2005	Shpak, Eran	455/69
*	B	US-7,054,640	05-2006	Bing et al.	455/452.1
*	C	US-2002/0193133	12-2002	Shibutani, Akira	455/522
*	D	US-2004/0132458	07-2004	Bing et al.	455/452.2
*	E	US-2004/0022219	02-2004	Mangold et al.	370/336
*	F	US-2003/0100328	05-2003	Klein et al.	455/522
*	G	US-2004/0037247	02-2004	Ngo, Chiu Y.	370/332
*	H	US-2002/0090966	07-2002	Hansen et al.	455/522
*	I	US-2004/0038697	02-2004	Attar et al.	455/522
*	J	US-5,724,346	03-1998	Kobayashi et al.	370/329
*	K	US-2004/0202141	10-2004	Sinivaara et al.	370/338
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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